

**Notice of References Cited**

Application/Control No.

09/994,096

Applicant(s)/Patent Under  
Reexamination  
CHEN ET AL.

Examiner

Charles Kim

Art Unit

2623

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0114495	08-2002	Chen et al.	382/117
	B	US-2003/0021448	01-2003	Chen et al.	382/117
	C	US-2002/0106112	08-2002	Chen et al.	382/117
	D	US-6,108,446	08-2000	Hoshen, Joseph	382/225
	E	US-5,878,156	03-1999	Okumura, Tomoko	382/118
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.